



20V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)} Max	I _D Max T _A = +25°C
20V	8mΩ @ V _{GS} = 10V	12.8A
	9mΩ @ V _{GS} = 4.5V	12.1A
	$12m\Omega$ @ $V_{GS} = 2.5V$	10.5A

Description and Applications

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- Power Management Functions
- DC-DC Converters

Features

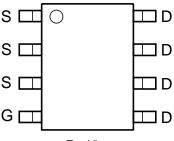
- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

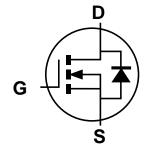
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 3 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.074 grams (Approximate)







Top View Internal Schematic



Equivalent Circuit

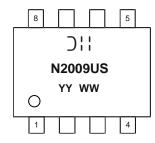
Ordering Information (Note 4)

Part Number	Case	Packaging
DMN2009USS-13	SO-8	2500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- See http://www.diodes.com/quality/lead_free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

Marking Information



);; = Manufacturer's Marking
N2009US = Product Type Marking Code
YYWW = Date Code Marking
YY or YY = Year (ex: 18 = 2018)
WW = Week (01 to 53)



Maximum Ratings (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V _{DSS}	20	V
Gate-Source Voltage			V _{GSS}	±12	V
Drain Current (Note 6) V _{GS} = 4.5V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	12.1 9.7	А
Maximum Continuous Body Diode Forward Current (Note 6)			I _S	3	Α
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)			I _{DM}	100	Α

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	P _D	1.4	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 5)	$R_{ hetaJA}$	90	°C/W
Total Power Dissipation (Note 6)	P _D	2.0	W
Thermal Resistance, Junction to Ambient @T _A = +25°C (Note 6)	$R_{ hetaJA}$	63	°C/W
Operating and Storage Temperature Range	T _{J,} T _{STG}	-55 to +150	°C

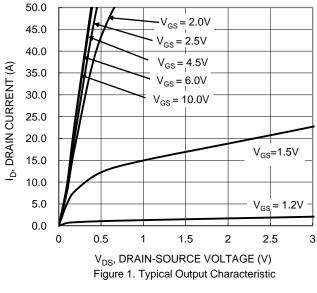
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	20	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μA	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_		±100	nA	$V_{GS} = \pm 12V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)						·	
Gate Threshold Voltage	V _{GS(TH)}	0.5	0.7	1.2	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
			6.3	8		$V_{GS} = 10V, I_D = 12A$	
Static Drain-Source On-Resistance	R _{DS(ON)}	_	6.7	9	mΩ	$V_{GS} = 4.5V, I_D = 10A$	
	, ,		8.7	12		$V_{GS} = 2.5V, I_D = 8A$	
Diode Forward Voltage	V_{SD}	0.5	0.63	1.2	V	$V_{GS} = 0V, I_{S} = 3A$	
DYNAMIC CHARACTERISTICS (Note 8)						·	
Input Capacitance	C _{iss}	_	1706		pF		
Output Capacitance	Coss	_	383	_	pF	$V_{DS} = 10V, V_{GS} = 0V, f = 1MHz$	
Reverse Transfer Capacitance	C _{rss}	_	176	_	pF		
Gate Resistance	R_g	_	3.0	_	Ω	$V_{GS} = 0V V_{DS} = 0V, f = 1MHz$	
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	16	_			
Total Gate Charge (V _{GS} = 10V)	Qg	_	34	_	nC	\/ 10\/ L 0.5A	
Gate-Source Charge	Qgs	_	1.9	_	iiC	$V_{DS} = 10V, I_D = 8.5A$	
Gate-Drain Charge	Q_{gd}	_	4.5	_			
Turn-On Delay Time	t _{D(ON)}	_	4.2	_	ns	$V_{DS} = 10V, I_{D} = 8.5A$ $V_{GS} = 4.5V, R_{g} = 1.8\Omega$	
Turn-On Rise Time	t _R	_	6.2	_	ns		
Turn-Off Delay Time	t _{D(OFF)}	_	25	_	ns		
Turn-Off Fall Time	t _F	_	11	_	ns		
Body Diode Reverse Recovery Time	t _{RR}	_	12	_	ns	1 0.50 4:/44 0400/	
Body Diode Reverse Recovery Charge	Q_{RR}	_	4.7	_	nC	$I_F = 8.5A$, di/dt = 210A/ μ s	

Notes:

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to product testing.





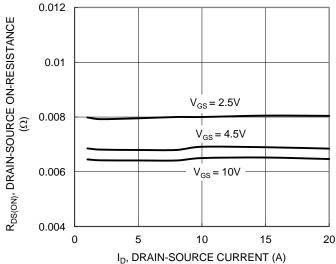


Figure 3. Typical On-Resistance vs .Drain Current and Gate Voltage

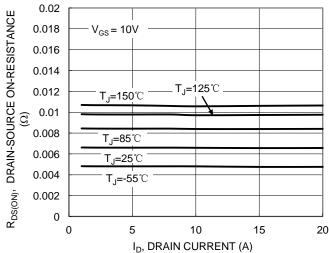
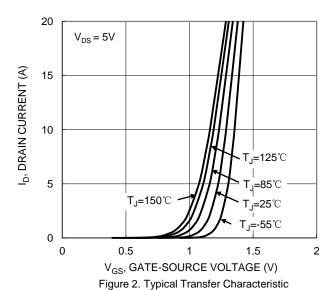
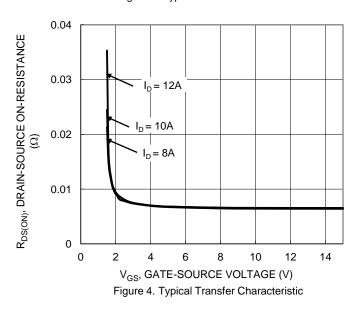


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature





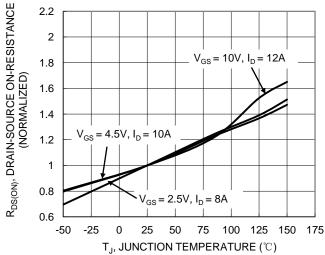


Figure 6. On-Resistance Variation with Junction Temperature



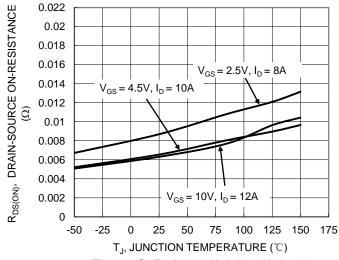


Figure 7. On-Resistance Variation with Junction Temperature

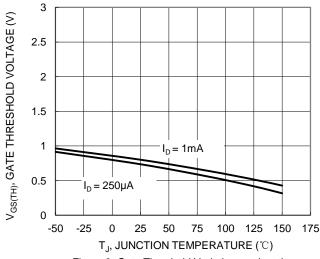


Figure 8. Gate Threshold Variation vs. Junction Temperature

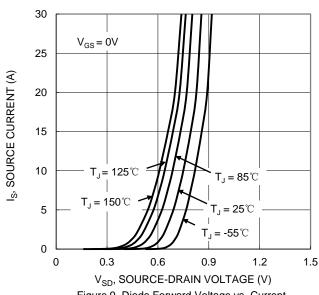
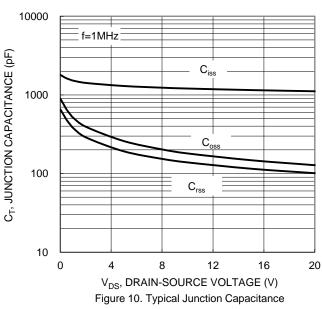
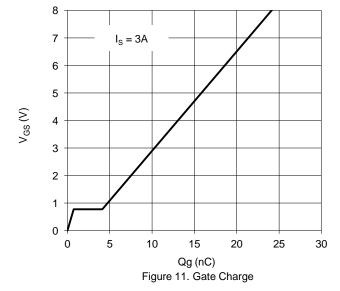


Figure 9. Diode Forward Voltage vs. Current



1000 $P_W = 100 \mu s$



 $R_{DS(ON)}$ Limited P_W =1ms 100 =10ms ID, DRAIN CURRENT (A) =100ms 10 $T_{J(Max)} = 150^{\circ}C$ $T_C = 25^{\circ}C$ Single Pulse DUT on 1*MRP DC $V_{GS} = 10V$ 0.01 0.1 10 100 V_{DS}, DRAIN-SOURCE VOLTAGE (V)

Figure 12. SOA, Safe Operation Area



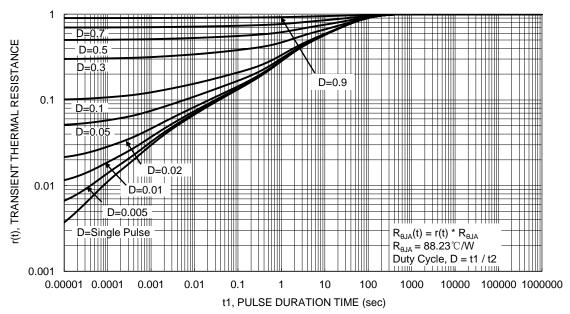
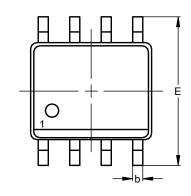


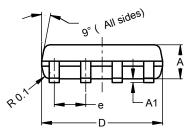
Figure 13. Transient Thermal Resistance

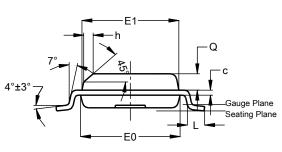


Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.







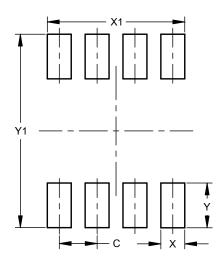
SO-8

SO-8					
Dim	Min	Max	Тур		
Α	1.40	1.50	1.45		
A1	0.10	0.20	0.15		
b	0.30	0.50	0.40		
C	0.15	0.25	0.20		
D	4.85	4.95	4.90		
Е	5.90	6.10	6.00		
E1	3.80	3.90	3.85		
E0	3.85	3.95	3.90		
е			1.27		
h	-		0.35		
L	0.62	0.82	0.72		
Q	0.60	0.70	0.65		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

SO-8



Dimensions	Value (in mm)
С	1.27
Х	0.802
X1	4.612
Υ	1.505
Y1	6.50



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